

# **OptiMOS®-T2 Power-Transistor**





#### **Features**

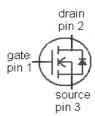
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green Product (RoHS compliant)
- 100% Avalanche tested

#### **Product Summary**

V <sub>DS</sub>	40	V
R <sub>DS(on),max</sub> (SMD version)	1.8	mΩ
I <sub>D</sub>	120	Α

PG-TO263-3-2 PG-TO262-3-1 PG-TO220-3-1

Туре	Package	Marking
IPB120N04S4-02	PG-TO263-3-2	4N0402
IPI120N04S4-02	PG-TO262-3-1	4N0402
IPP120N04S4-02	PG-TO220-3-1	4N0402



### **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	T <sub>C</sub> =25°C, V <sub>GS</sub> =10V	120	А
		$T_{\rm C}$ =100°C, $V_{\rm GS}$ =10 $V^{2)}$	120	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25°C	480	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	I <sub>D</sub> =60A	480	mJ
Avalanche current, single pulse	IAS	-	120	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> =25°C	158	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 <b>+</b> 175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



## IPB120N04S4-02 IPI120N04S4-02, IPP120N04S4-02

Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	-	0.95	K/W
Thermal resistance, junction - ambient, leaded	$R_{ m thJA}$	-	-	-	62	
SMD version, device on PCB	$R_{\mathrm{thJA}}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	1

# **Electrical characteristics,** at $T_{\rm j}$ =25 °C, unless otherwise specified

#### **Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{\rm GS}$ =0V, $I_{\rm D}$ = 1mA	40	1	ı	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 110 \mu {\rm A}$	2.0	3.0	4.0	
Zero gate voltage drain current	IDSS	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V	1	0.05	1	μΑ
		$V_{\rm DS}$ =18V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =85°C <sup>2)</sup>	1	1	20	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =100A	-	1.88	2.1	mΩ
		V <sub>GS</sub> =10V, I <sub>D</sub> =100A, SMD version	-	1.58	1.8	



Parameter	Symbol	Symbol Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	8260	10740	pF
Output capacitance	Coss	$V_{\rm GS}$ =0V, $V_{\rm DS}$ =25V, f=1MHz	-	1850	2405	
Reverse transfer capacitance	C <sub>rss</sub>		-	60	138	
Turn-on delay time	$t_{d(on)}$		-	27	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =20V, V <sub>GS</sub> =10V,	-	16	-	- - -
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =120A, $R_{\rm G}$ =3.5 $\Omega$	-	30	-	
Fall time	t <sub>f</sub>		-	30	-	
Gate Charge Characteristics <sup>2)</sup>			1	T		T
Gate to source charge	Q <sub>gs</sub>		-	44	57	nC
Gate to drain charge	Q <sub>gd</sub>	$V_{\rm DD}$ =32V, $I_{\rm D}$ =120A, $V_{\rm GS}$ =0 to 10V	-	14	32	
Gate charge total	Q <sub>g</sub>		-	103	134	
Gate plateau voltage	$V_{ m plateau}$		-	5.3	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T -25°C	-	-	120	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	− <i>T</i> <sub>C</sub> =25°C	-	-	480	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =100A, T <sub>j</sub> =25°C	-	0.9	1.3	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	$V_R$ =20V, $I_F$ =50A, $di_F/dt$ =100A/ $\mu$ s	-	60	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>		-	65	-	nC

<sup>&</sup>lt;sup>1)</sup> Current is limited by bondwire; with an  $R_{\rm thJC}$  = 0.95K/W the chip is able to carry 229A at 25°C.

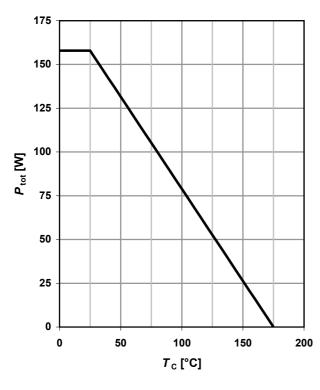
 $<sup>^{\</sup>rm 2)}$  Defined by design. Not subject to production test.

 $<sup>^{3)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



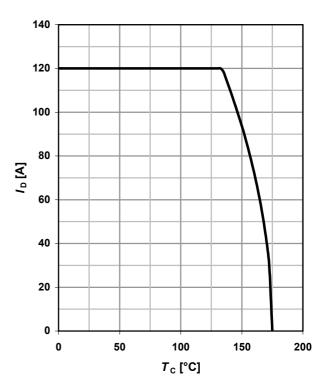
#### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$



#### 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}; \text{SMD}$$



#### 3 Safe operating area

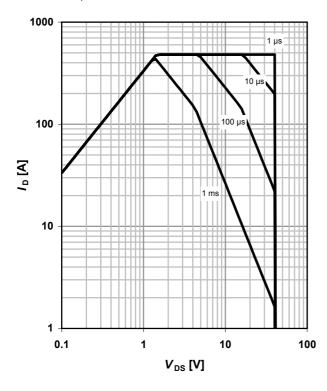
$$I_D = f(V_{DS}); T_C = 25 \,^{\circ}\text{C}; D = 0; \text{SMD}$$

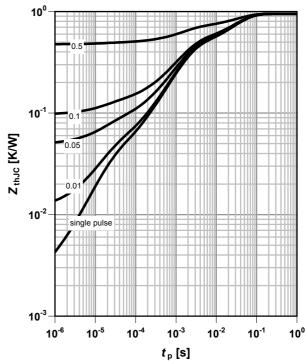
parameter: t<sub>p</sub>

#### 4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter:  $D = t_p/T$ 



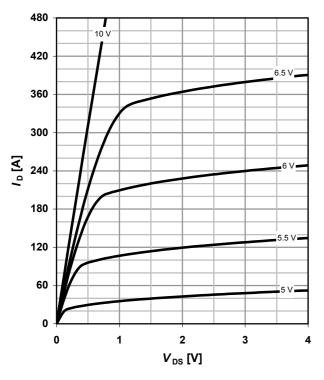




#### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C; SMD$ 

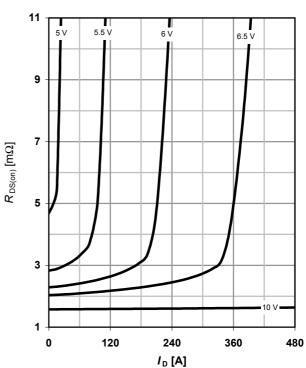
parameter:  $V_{\rm GS}$ 



#### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}; SMD$ 

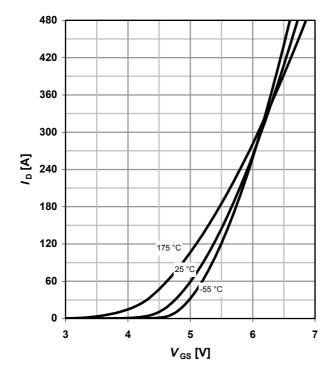
parameter: V<sub>GS</sub>



#### 7 Typ. transfer characteristics

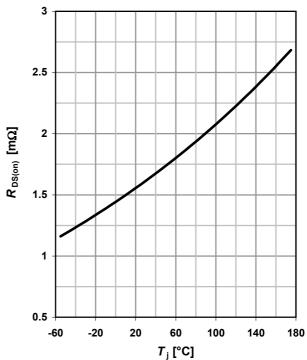
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter: T<sub>i</sub>



#### 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}; \text{SMD}$$





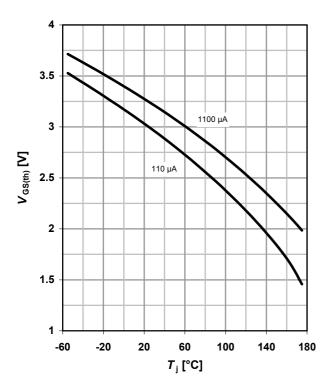
#### 9 Typ. gate threshold voltage

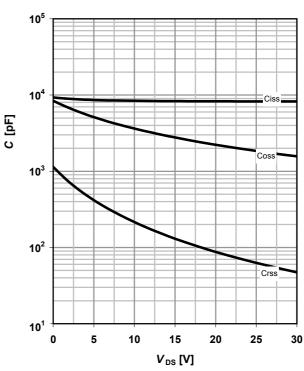
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

### 10 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$





#### 11 Typical forward diode characteristicis

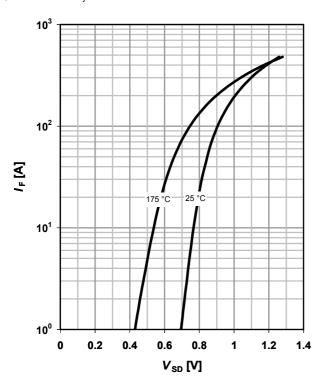
 $IF = f(V_{SD})$ 

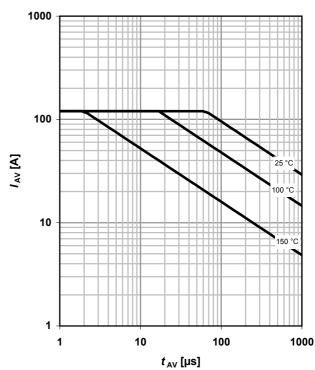
parameter: T<sub>i</sub>

#### 12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>







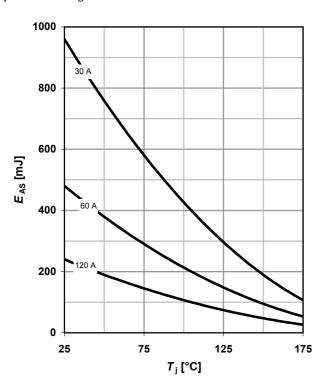
#### 13 Avalanche energy

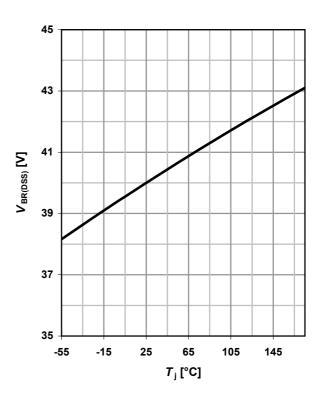
### $E_{AS} = f(T_i)$

parameter:  $I_D$ 

#### 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

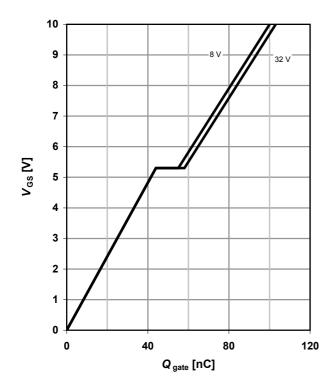




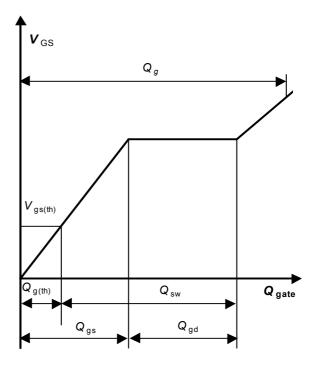
### 15 Typ. gate charge

 $V_{\rm GS}$  = f( $Q_{\rm gate}$ );  $I_{\rm D}$  = 120 A pulsed

parameter:  $V_{\rm DD}$ 



#### 16 Gate charge waveforms





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## IPB120N04S4-02 IPI120N04S4-02, IPP120N04S4-02

## Revision History

Version	Date	Changes
Revision 1.0	06.04.2010	Final Data Sheet